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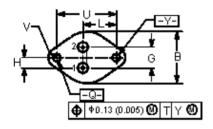
High-power industrial transistors.

NPN silicon power transistor designed for applications in industrial and commercial equipment including high fidelity audio amplifiers, series and shunt regulators and power switches.

Features:

- Collector-emitter sustaining voltage V_{CEO (sus)} = 140V dc (minimum).
- Excellent second breakdown capability.
- Pb-free package.

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Le L-T- Seating Plane	
↔ + D 2PL LK ⊕ +0.13 (0.005) ❷ T Q ❷ Y ❷	



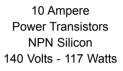
Style 1:

Pin 1. Base

2. Emitter Collector (Case)

Dimensions	Minimum	Maximum	
A	1.550 (39.37) Reference		
В	-	1.050 (26.67)	
С	0.250 (6.35)	0.335 (8.51)	
D	0.038 (0.97)	0.043 (1.09)	
E	0.055 (1.40)	0.070 (1.77)	
G	0.430 (10.92) BSC		
Н	0.215 (5.46) BSC		
к	0.440 (11.18) 0.480 (12.1		
L	0.665 (16.89) BSC		
N	- 0.830 (21.0		
Q	0.151 (3.84)	0.165 (4.19)	
U	1.187 (30.15) BSC		
V	0.131 (3.33)	0.188 (4.77)	

Dimensions : Inches (Millimetres)





(TO-3) Case 1-07 Style 1

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Maximum Ratings (Note 1)

Rating	Symbol	Value	Unit
Collector-Emitter Voltage	V _{CEO}	140	
Collector-Base Voltage	V _{CB} 160		V dc
Emitter-Base Voltage	V _{EB}	7.0	
Collector Current - Continuous - Peak	Ι _C	10 15	A dc
Base Current - Continuous - Peak	Ι _Β	7.0	Adc
Total Device Dissipation at T _C = 25°C Derate above 25°C (Note 2)	P _D	117 0.67	W W/°C
Operating and Storage Junction Temperature Range	T _{J,} T _{stg}	-65 to +200	°C

Thermal Characteristics

Characteristics	Symbol	Maximum	Unit
Thermal Resistance, Junction-to-Case	$R_{ extsf{ heta}JC}$	1.17	°C/W

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

1. Indicates JEDEC registered data.

2. This data guaranteed in addition to JEDEC registered data.

Electrical Characteristics (T_c = 25°C unless otherwise noted)

Characteristic	Symbol	Minimum	Maximum	Unit
Off Characteristics				
Collector-Emitter Sustaining Voltage (I_C = 200mA dc, I_B = 0)	V _{EO (sus)}	140	-	V dc
Collector Cut off Current (V_{CE} = 140V dc, I_B = 0)	I _{CEO}	-	200	
Collector Cut off Current (V _{CE} = 140 V dc, V _{BE (off)} = 1.5 V dc) (V _{CE} = 140V dc, V _{BE (off)} = 1.5V dc, T _C = 150°C)	I _{CEX}	-	5.0 30	mA dc
Emitter Cut off Current (V_{EB} = 7.0V dc I _C = 0)	I _{EBO}	-	5.0	



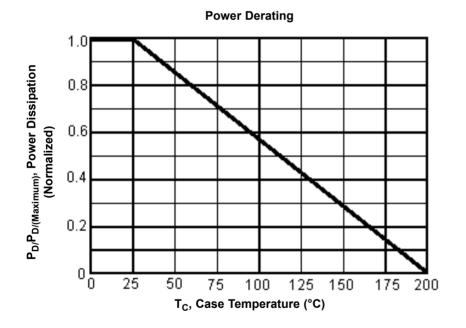


Electrical Characteristics (T_c = 25°C unless otherwise noted)

Characteristic	Symbol	Minimum	Maximum	Unit
On Characteristic (Note 3)				
DC Current Gain ($I_C = 3.0A dc$, $V_{CE} = 4.0V dc$) ($I_C = 10A dc$, $V_{CE} = 4.0V dc$)	h _{FE}	2.0 7.5	70 -	-
Collector-Emitter Saturation Voltage $(I_{C} = 10A \text{ dc}, I_{B} = 2.0A \text{ dc})$	V _{CE (sat)}	-	5.0	V dc
Base-Emitter On Voltage (I _C = 10A dc, V _{CE} = 4.0V dc)	V _{BE (on)}	-	5.7	
Dynamic Characteristics	I		11	
Current-Gain - Bandwidth Product (Note 4) ($I_C = 2.0A \text{ dc}, V_{CE} = 4.0V \text{ dc}, f_{test} = 40 \text{kHz}$)	f _T	80	-	kHz
Small-Signal Current Gain (I _C = 2.0A dc, V _{CE} = 4.0V dc, f = 1.0kHz)	h _{fe}	12	72	-

3. Pulse Test : Pulse Width = 300 $\mu s,$ Duty Cycle $\leq 2.0\%.$

4. $f_T = |h_{fe}| \bullet f_{test}$.





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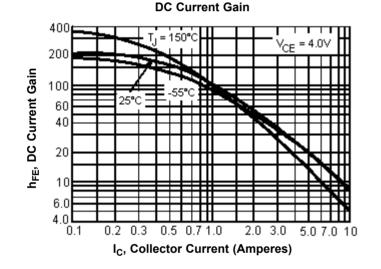


20 S c, Collector Current (Amperes) 10 7.0 5.0 3045 3.0 2.0 50410049 1.0 1 0ms Current Limit 0.7 -100ms Thermal Limit at T_C = 25' 0.5 Single Pulse 0.3 Second Breakdown Limit 0.2 2.0 3.0 5.0 7.0 10 20 30 50 70 100 200 V_{CE}, Collector Emitter Voltage (Volts)

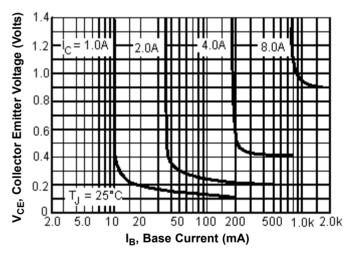
Active-Region Safe Operating Area Information

There are two limitation on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate I_C - V_{CE} limits of the transistor that must be observed for reliable operation i.e., the transistor must not be subjected to greater dissipation than curves indicate.

The data is based on T_{J (PK)} = 200°C; T_C is variable depending on conditions. At high case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown.



Collector-Saturation Region



Part Number Table

Description	Part Number
Transistor, NPN, TO-3	2N3442

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